

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/616,631	YAMATO ET AL.	
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Noble S. Wong		2173		

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,539,869 A	07-1996	Spoto et al.	715/500.1
*	B	US-5,742,286 A	04-1998	Kung et al.	715/839
*	C	US-5,857,201 A	01-1999	Wright et al.	707/104.1
*	D	US-6,324,542 B1	11-2001	Wright et al.	707/104.1
*	E	US-6,456,892 B1	09-2002	Dara-Abrams et al.	700/83
*	F	US-6,526,335 B1	02-2003	Treyz et al.	701/1
*	G	US-6,550,054 B1	04-2003	Stefaniak, Joseph Peter	717/104
*	H	US-6,615,088 B1	09-2003	Myer et al.	700/20
*	I	US-6,738,806 B1	05-2004	Maryka et al.	709/220
*	J	US-6,834,285 B1	12-2004	Boris et al.	707/103R
*	K	US-6,829,655 B1	12-2004	Huang et al.	709/248
*	L	US-6,965,928 B1	11-2005	Cox et al.	709/220
*	M	US-6,983,317 B1	01-2006	Bishop et al.	709/223

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

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<b>Notice of References Cited</b>	Application/Control No. 10/616,631	Applicant(s)/Patent Under Reexamination YAMATO ET AL.
	Examiner Noble S. Wong	Art Unit 2173

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,204,813 A	04-1993	Samph et al.	434/362
*	B	US-5,782,642 A	07-1998	Goren, Michael	434/307R
*	C	US-6,330,618 B1	12-2001	Hawkins et al.	709/248
*	D	US-6,535,976 B1	03-2003	Hoggarth et al.	713/2
*	E	US-6,792,323 B2	09-2004	Krzyzanowski et al.	700/90
*	F	US-6,886,060 B2	04-2005	Wang et al.	710/72
*	G	US-6,934,777 B2	08-2005	Kawamura et al.	710/62
*	H	US-7,039,858 B2	05-2006	Humbleman et al.	715/501.1
*	I	US-7,082,341 B2	07-2006	Lee, Koon Seok	700/90
*	J	US-6,336,147	01-2002	Brownell et al.	719/310
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
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